

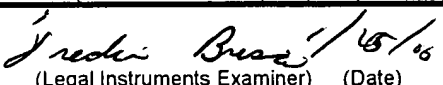


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/098,550	CHEN, LIN-HUNG	
	Examiner	Art Unit	
	Kim T. Huynh	2112	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
710	314				305	306	100	3		
INTERNATIONAL CLASSIFICATION										
G	0	6	F	13/36						
				/						
				/						
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				/						
Kim T. Huynh 1/18/06 (Assistant Examiner) (Date)					 <b>REHANA PERVEEN</b> SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 1/19/06			Total Claims Allowed: 13		
 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 3	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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